Application/Control No. 10/040,488 Applicant(s)/Patent Under Reexamination NAKANO ET AL. Examiner HUY T NGUYEN Applicant(s)/Patent Under Reexamination NAKANO ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	А	US-5,594,736 A	01-1997	Tatsumi et al.	370/474
	В	US-5,440,401 A	08-1995	Parulski et al.	386/124
	С	US-5,371,602 A	12-1994	Tsuboi et al.	386/111
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	2					
	0					
	Ը					
	ø					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	w	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.